

PSMN1R2-30YLD

N-channel 30 V, 1.2 m Ω logic level MOSFET in LFPAK56 using NextPowerS3 Technology

7 October 2013

Objective data sheet

1. General description

Logic level gate drive N-channel enhancement mode MOSFET in LFPAK56 package. NextPowerS3 portfolio utilising NXP's unique "SchottkyPlus" technology delivers high efficiency, low spiking performance usually associated with MOSFETs with an integrated Schottky or Schottky-like diode but without problematic high leakage current. NextPowerS3 is particularly suited to high efficiency applications at high switching frequencies.

2. Features and benefits

- Ultra low Q_G, Q_{GD} and Q_{OSS} for high system efficiency, especially at higher switching frequencies
- Superfast switching with soft-recovery; s-factor > 1
- Low spiking and ringing for low EMI designs
- Unique "SchottkyPlus" technology; Schottky-like performance with < 1 μA leakage at 25 °C
- Optimised for 4.5 V gate drive
- Low parasitic inductance and resistance
- High reliability clip bonded and solder die attach Power SO8 package; no glue, no wire bonds, gualified to 175 °C
- Wave solderable; exposed leads for optimal visual solder inspection

3. Applications

- On-board DC-to-DC solutions for server and telecommunications
- Secondary-side synchronous rectification in telecommunication applications
- Voltage regulator modules (VRM)
- Point-of-Load (POL) modules
- Power delivery for V-core, ASIC, DDR, GPU, VGA and system components
- Brushed and brushless motor control
- Power OR-ing

4. Quick reference data

Table 1. Quick reference data

| Symbol | Parameter | Conditions | | Min | Тур | Max | Unit |
|------------------|-------------------------|--|-----|-----|-----|-----|------|
| V _{DS} | drain-source voltage | 25 °C ≤ T _j ≤ 175 °C | | - | - | 30 | V |
| I _D | drain current | T _{mb} = 25 °C; V _{GS} = 10 V; <u>Fig. 1</u> | [1] | - | - | 100 | Α |
| P _{tot} | total power dissipation | T _{mb} = 25 °C; <u>Fig. 2</u> | | - | - | 194 | W |





| Symbol | Parameter | Conditions | Mir | т Тур | Max | Unit |
|---------------------|-----------------------|--|-----|-------|------|------|
| Tj | junction temperature | | -55 | 5 - | 175 | °C |
| Static char | acteristics | | 1 | ' | | |
| R _{DSon} | drain-source on-state | V_{GS} = 4.5 V; I_{D} = 25 A; T_{j} = 25 °C | - | 1.4 | 1.6 | mΩ |
| | resistance | V _{GS} = 10 V; I _D = 25 A; T _j = 25 °C | - | 1.09 | 1.24 | mΩ |
| Dynamic cl | haracteristics | | | 1 | | |
| Q_{GD} | gate-drain charge | V_{GS} = 4.5 V; I_D = 25 A; V_{DS} = 15 V; Fig. 7 | - | [tbd] | - | nC |
| Q _{G(tot)} | total gate charge | $V_{GS} = 4.5 \text{ V}; I_D = 25 \text{ A}; V_{DS} = 15 \text{ V};$ Fig. 7 | - | [tbd] | - | nC |
| Source-dra | in diode | 1 | 1 | 1 | | |
| S | softness factor | I_S = 25 A; V_{GS} = 0 V; dI_S/dt = -100 A/ μ s; V_{DS} = 15 V; Fig. 8 | - | [tbd] | - | |

^[1] Continuous current is limited by package.

5. Pinning information

Table 2. Pinning information

| Pin | Symbol | Description | Simplified outline | Graphic symbol |
|-----|--------|-----------------------------------|--|----------------|
| 1 | S | source | mb | D I |
| 2 | S | source | | |
| 3 | S | source | q | G |
| 4 | G | gate | و ق ق ق | mbb076 S |
| mb | D | mounting base; connected to drain | 1 2 3 4 LFPAK56; Power- SO8 (SOT669) | |

6. Ordering information

Table 3. Ordering information

| Type number | Package | | | | |
|---------------|-----------------------|--|---------|--|--|
| | Name | Description | Version | | |
| PSMN1R2-30YLD | LFPAK56; Power-SO8 | Plastic single-ended surface-mounted package (LFPAK56; Power-SO8); 4 leads | SOT669 | | |

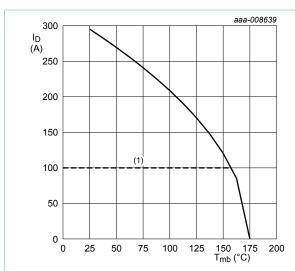
Limiting values 7.

Table 4. **Limiting values**

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol | Parameter | Conditions | | Min | Max | Unit |
|----------------------|--|---|-----|-------|------|------|
| V_{DS} | drain-source voltage | 25 °C ≤ T _j ≤ 175 °C | | - | 30 | V |
| V_{DGR} | drain-gate voltage | 25 °C ≤ T_j ≤ 175 °C; R_{GS} = 20 kΩ | | - | 30 | V |
| V _{GS} | gate-source voltage | | | -20 | 20 | V |
| I _D | drain current | V _{GS} = 10 V; T _{mb} = 25 °C; <u>Fig. 1</u> | [1] | - | 100 | Α |
| | | V _{GS} = 10 V; T _{mb} = 100 °C; <u>Fig. 1</u> | [1] | - | 100 | Α |
| I _{DM} | peak drain current | pulsed; $t_p \le 10 \mu s$; $T_{mb} = 25 \text{ °C}$ | | - | 1181 | Α |
| P _{tot} | total power dissipation | T _{mb} = 25 °C; <u>Fig. 2</u> | | - | 194 | W |
| T _{stg} | storage temperature | | | -55 | 175 | °C |
| T _j | junction temperature | | | -55 | 175 | °C |
| T _{sld(M)} | peak soldering temperature | | | - | 260 | °C |
| V _{ESD} | electrostatic discharge voltage | НВМ | | [tbd] | - | V |
| Source-drain | diode | | | | | |
| I _S | source current | T _{mb} = 25 °C | [1] | - | 100 | Α |
| I _{SM} | peak source current | pulsed; $t_p \le 10 \mu s$; $T_{mb} = 25 \text{ °C}$ | | - | 1181 | Α |
| Avalanche rug | ggedness | | | | | , |
| E _{DS(AL)S} | non-repetitive drain-source avalanche energy | V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; I_D = 25 A; $V_{sup} \le$ 30 V; R_{GS} = 50 Ω; unclamped; t_p = 1.97 ms | [2] | - | 961 | mJ |

^[1] Continuous current is limited by package.[2] Protected by 100% test



(1) Capped at 100A due to package

Fig. 1. Continuous drain current as a function of mounting base temperature

$$V_{GS} \ge 10V$$

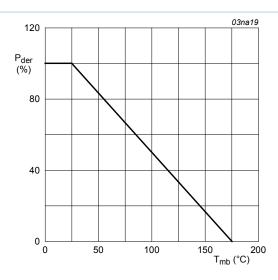


Fig. 2. Normalized total power dissipation as a function of mounting base temperature

$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100\%$$

8. Thermal characteristics

Table 5. Thermal characteristics

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|-----------------------|---|---------------|-----|-----------|------|------------|
| R _{th(j-mb)} | thermal resistance from junction to mounting base | Fig. 5 | - | 0.69 | 0.77 | K/W |
| R _{th(j-a)} | thermal resistance from junction to ambient | Fig. 3 Fig. 4 | - | 50 125 | - | K/W K/W |

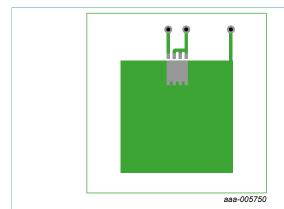


Fig. 3. PCB layout for thermal resistance junction to ambient 1" square pad; FR4 Board; 2oz copper

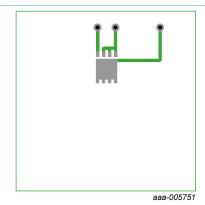
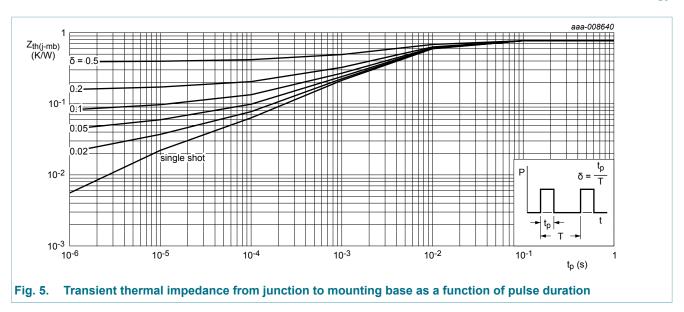


Fig. 4. PCB layout for thermal resistance junction to ambient minimum footprint; FR4 Board; 2oz copper



9. Characteristics

Table 6. Characteristics

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|------------------------------|--|---|-----|-------|------|------|
| Static charac | teristics | | | | | |
| V _{(BR)DSS} | drain-source | $I_D = 250 \mu A; V_{GS} = 0 V; T_j = 25 °C$ | 30 | - | - | V |
| | breakdown voltage | $I_D = 250 \ \mu A; \ V_{GS} = 0 \ V; \ T_j = -55 \ ^{\circ}C$ | 27 | - | - | V |
| $V_{GS(th)}$ | gate-source threshold voltage | $I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ °C}$ | 1.2 | [tbd] | 2.2 | V |
| $\Delta V_{GS(th)}/\Delta T$ | gate-source threshold voltage variation with temperature | 25 °C ≤ T _j ≤ 150 °C | - | [tbd] | - | mV/K |
| I _{DSS} | drain leakage current | V_{DS} = 24 V; V_{GS} = 0 V; T_j = 25 °C | - | - | 1 | μA |
| | | V _{DS} = 24 V; V _{GS} = 0 V; T _j = 150 °C | - | - | 100 | μA |
| I _{GSS} | gate leakage current | V _{GS} = 16 V; V _{DS} = 0 V; T _j = 25 °C | - | - | 100 | nA |
| | | V_{GS} = -16 V; V_{DS} = 0 V; T_j = 25 °C | - | - | 100 | nA |
| R _{DSon} | drain-source on-state | V_{GS} = 4.5 V; I_D = 25 A; T_j = 25 °C | - | 1.4 | 1.6 | mΩ |
| | resistance | $V_{GS} = 4.5 \text{ V}; I_D = 25 \text{ A}; T_j = 150 ^{\circ}\text{C};$ Fig. 6 | - | - | 2.64 | mΩ |
| | | V _{GS} = 10 V; I _D = 25 A; T _j = 25 °C | - | 1.09 | 1.24 | mΩ |
| | | V_{GS} = 10 V; I_D = 25 A; T_j = 150 °C; Fig. 6 | - | - | 2.05 | mΩ |
| R_G | gate resistance | f = 1 MHz | - | 1 | - | Ω |

| Symbol | Parameter | Conditions | Mir | т Тур | Max | Unit |
|------------------------|---------------------------------------|--|-------|-------|-----|------|
| Dynamic ch | naracteristics | | | ' | | |
| Q _{G(tot)} | total gate charge | I _D = 25 A; V _{DS} = 15 V; V _{GS} = 10 V; Fig. 7 | - | [tbd] | - | nC |
| | | I _D = 25 A; V _{DS} = 15 V; V _{GS} = 4.5 V; Fig. 7 | - | [tbd] | - | nC |
| | | I _D = 0 A; V _{DS} = 0 V; V _{GS} = 10 V | - | [tbd] | - | nC |
| Q _{GS} | gate-source charge | I _D = 25 A; V _{DS} = 15 V; V _{GS} = 4.5 V; | - | [tbd] | - | nC |
| Q _{GS(th)} | pre-threshold gate- source charge | Fig. 7 | - | [tbd] | - | nC |
| Q _{GS(th-pl)} | post-threshold gate- source charge | | - | [tbd] | - | nC |
| Q_{GD} | gate-drain charge | | - | [tbd] | - | nC |
| V _{GS(pl)} | gate-source plateau voltage | I _D = 25 A; V _{DS} = 15 V; <u>Fig. 7</u> | - | [tbd] | - | V |
| C _{iss} | input capacitance | V_{DS} = 15 V; V_{GS} = 0 V; f = 1 MHz; T_j = 25 °C | - | [tbd] | - | pF |
| C _{oss} | output capacitance | | - | [tbd] | - | pF |
| C _{rss} | reverse transfer capacitance | | - | [tbd] | - | pF |
| t _{d(on)} | turn-on delay time | V_{DS} = 15 V; R_L = 0.6 Ω ; V_{GS} = 4.5 V; | - | [tbd] | - | ns |
| t _r | rise time | $R_{G(ext)} = 5 \Omega$ | - | [tbd] | - | ns |
| t _{d(off)} | turn-off delay time | | - | [tbd] | - | ns |
| t _f | fall time | | - | [tbd] | - | ns |
| Q _{oss} | output charge | $V_{GS} = 0 \text{ V}; V_{DS} = 15 \text{ V}; f = 1 \text{ MHz};$ $T_j = 25 \text{ °C}$ | - | [tbd] | - | nC |
| Source-dra | in diode | | | ' | - | |
| V _{SD} | source-drain voltage | $I_S = 25 \text{ A}; V_{GS} = 0 \text{ V}; T_j = 25 ^{\circ}\text{C}$ | - | [tbd] | 1.2 | V |
| t _{rr} | reverse recovery time | $I_S = 25 \text{ A}; dI_S/dt = -100 \text{ A/}\mu\text{s}; V_{GS} = 0 \text{ V};$ | - | [tbd] | - | ns |
| Q _r | recovered charge | V _{DS} = 15 V; <u>Fig. 8</u> | [1] - | [tbd] | - | nC |
| ta | reverse recovery rise time | | - | [tbd] | - | ns |
| t _b | reverse recovery fall time | | - | [tbd] | - | ns |
| S | softness factor | 1 | - | [tbd] | - | |

^[1] includes capacitive recovery

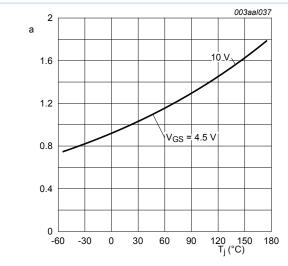


Fig. 6. Normalized drain-source on-state resistance factor as a function of junction temperature

$$a = \frac{R_{DSon}}{R_{DSon (25^{\circ}C)}}$$

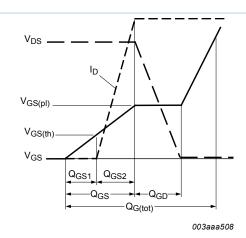


Fig. 7. Gate charge waveform definitions

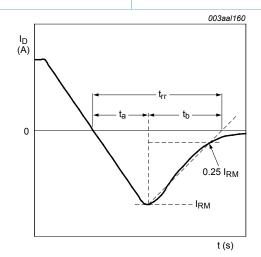
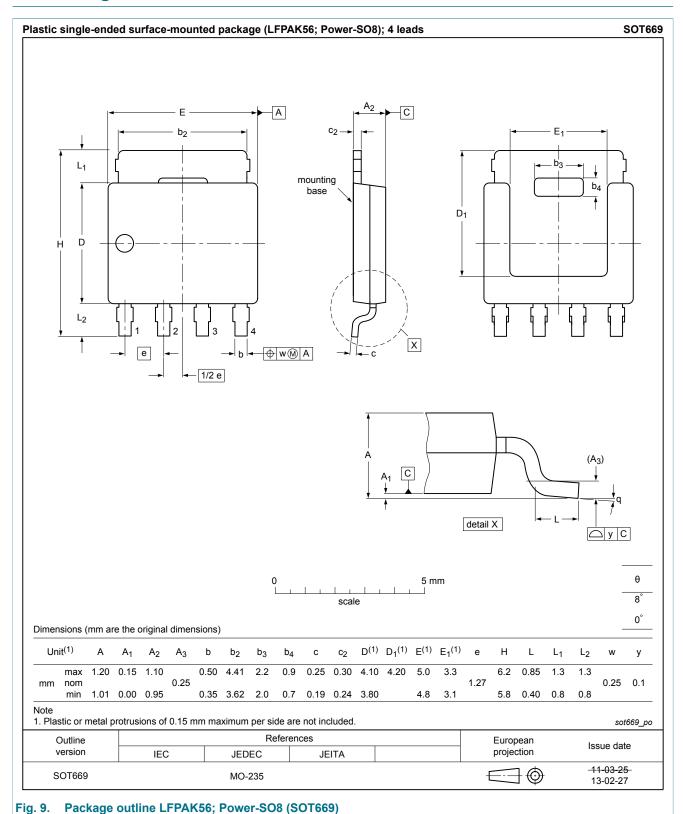


Fig. 8. Reverse recovery timing definition

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10. Package outline



11. Legal information

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| Document status [1][2] | Product status [3] | Definition |
|--------------------------------------|--------------------|---|
| Objective [short] data sheet | Development | This document contains data from the objective specification for product development. |
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